Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/647,377	KONNO ET AL.
Examiner	Art Unit
Lamson D. Nguyen	2861

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Class	Subclass	Date	Examiner
347	40	6/22/05	-a
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
347	43	6/22/05			
347	4/	6/22/05			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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